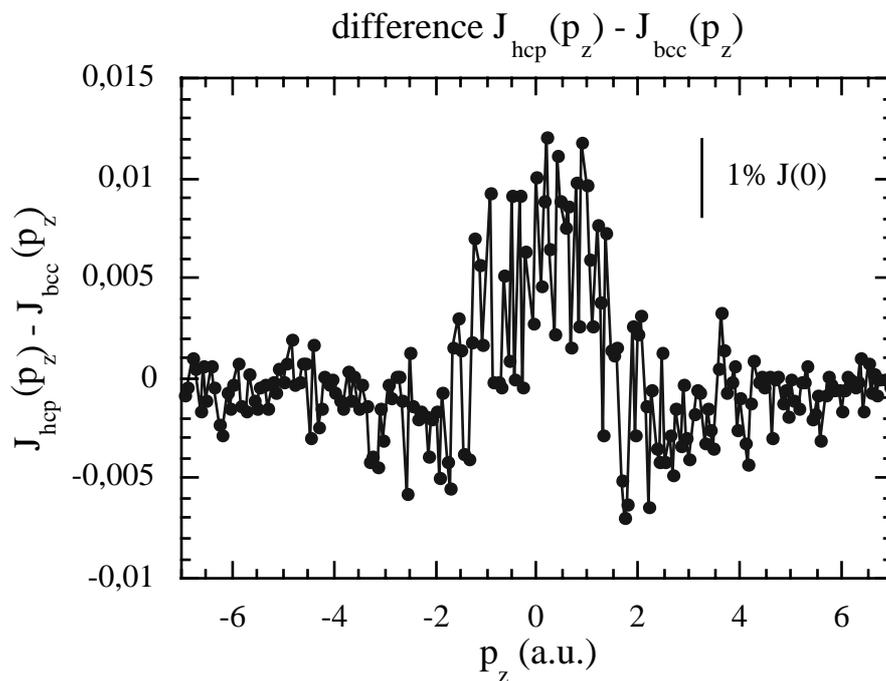




diffraction measurements : two Compton profiles, one for bcc iron and the other for hcp iron. The geometry of the experiment allowed us to shield very carefully the anvils in order to minimize the anvil contribution to inelastic scattering : photons scattered by the sample cross diamond before being detected and hence add to the iron Compton profile a profile due to inelastic scattering in diamond itself. We finally obtained that the contribution given to the Compton profile by the anvils is 50% of the total Compton profile detected. Nevertheless, if one makes the difference of both profiles measured just below and above transition temperature, contribution of diamond electrons to the Compton profiles will cancel as well as experimental systematic errors.

On the figure just below is shown the difference  $J_{\text{hcp}}(p_z) - J_{\text{bcc}}(p_z)$  between Compton profiles above and below the transition temperature :



First of all, one can observe that the signal difference is measurable, even with very low statistics : it is around 2% of  $J(0)$ ,  $J(0)$  being the value of the profile at  $p_z = 0$  a.u.. We usually wait in such difference of profiles a signal around 1% $J(0)$ .

As a conclusion, at the step of the data analysis now reached, we can say the following :

- the fact that Compton profile is made of the contribution of every electron met by the incident photons on their path and the very small volume of sample make the very “clean” optics of the beamline ID30 and its accurate focalisation to a size of the beam around  $30 \times 40 \mu\text{m}^2$  essential conditions for making such an experiment possible ;
- the shifts allocated have permitted to demonstrate the faisability of Compton scattering under pressure : the obtained signal is measurable, even if statistics is missing.